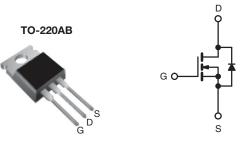


**Vishay Siliconix** 



### Power MOSFET

| PRODUCT SUMMARY            |                           |  |  |  |  |
|----------------------------|---------------------------|--|--|--|--|
| V <sub>DS</sub> (V)        | 1000                      |  |  |  |  |
| R <sub>DS(on)</sub> (Ω)    | V <sub>GS</sub> = 10 V 11 |  |  |  |  |
| Q <sub>g</sub> (Max.) (nC) | 38                        |  |  |  |  |
| Q <sub>gs</sub> (nC)       | 4.9                       |  |  |  |  |
| Q <sub>gd</sub> (nC)       | 22                        |  |  |  |  |
| Configuration              | Single                    |  |  |  |  |



N-Channel MOSFET

#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

#### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effictiveness.

The TO-220AB package is universially preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

| ORDERING INFORMATION |             |
|----------------------|-------------|
| Package              | TO-220AB    |
| Lead (Pb)-free       | IRFBG20PbF  |
| Lead (FD)-free       | SiHFBG20-E3 |
| SnPb                 | IRFBG20     |
| SIFD                 | SiHFBG20    |

| ABSOLUTE MAXIMUM RATINGS ( $T_C$                 | = 25 °C, unl            | ess otherwis            | se noted)                         |                  |          |  |
|--------------------------------------------------|-------------------------|-------------------------|-----------------------------------|------------------|----------|--|
| PARAMETER                                        |                         |                         | SYMBOL                            | LIMIT            | UNIT     |  |
| Drain-Source Voltage                             |                         |                         | V <sub>DS</sub>                   | 1000             | v        |  |
| Gate-Source Voltage                              |                         |                         | V <sub>GS</sub>                   | ± 20             | v        |  |
| Continuous Drain Current                         | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 25 °C  | - I <sub>D</sub>                  | 1.4              |          |  |
|                                                  |                         | T <sub>C</sub> = 100 °C |                                   | 0.86             | А        |  |
| Pulsed Drain Current <sup>a</sup>                |                         |                         | I <sub>DM</sub>                   | 5.6              |          |  |
| Linear Derating Factor                           |                         |                         |                                   | 0.43             | W/°C     |  |
| Single Pulse Avalanche Energy <sup>b</sup>       |                         |                         | E <sub>AS</sub>                   | 200              | mJ       |  |
| Repetitive Avalanche Current <sup>a</sup>        |                         |                         | I <sub>AR</sub>                   | 1.4              | А        |  |
| Repetitive Avalanche Energy <sup>a</sup>         |                         |                         | E <sub>AR</sub>                   | 5.4              | mJ       |  |
| Maximum Power Dissipation                        | T <sub>C</sub> =        | 25 °C                   | P <sub>D</sub>                    | 54               | W        |  |
| Peak Diode Recovery dV/dt <sup>c</sup>           |                         |                         | dV/dt                             | 1.0              | V/ns     |  |
| Operating Junction and Storage Temperature Range |                         |                         | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 150    |          |  |
| Soldering Recommendations (Peak Temperature)     | for 10 s                |                         |                                   | 300 <sup>d</sup> |          |  |
| Mounting Torque                                  | 6-32 or M3 screw        |                         |                                   | 10               | lbf ∙ in |  |
|                                                  |                         |                         |                                   | 1.1              | N · m    |  |

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C,  $L = 193 \ \mu$ H,  $R_g = 25 \ \Omega$ ,  $I_{AS} = 1.4$  A (see fig. 12).

c.  $I_{SD} \leq 1.4$  A, dI/dt  $\leq 60$  A/µs,  $V_{DD} \leq 600$ ,  $T_J \leq 150$  °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

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### Vishay Siliconix



| THERMAL RESISTANCE RATII<br>PARAMETER                      | SYMBOL                | TYP                                                                               |                                        | MAX.                                                    |            |           |          |       |
|------------------------------------------------------------|-----------------------|-----------------------------------------------------------------------------------|----------------------------------------|---------------------------------------------------------|------------|-----------|----------|-------|
|                                                            |                       |                                                                                   |                                        |                                                         |            | UNIT      |          |       |
| Maximum Junction-to-Ambient                                | R <sub>thJA</sub>     | - 62<br>0.50 -                                                                    |                                        |                                                         | °C/W       |           |          |       |
| Case-to-Sink, Flat, Greased Surface                        | R <sub>thCS</sub>     |                                                                                   |                                        |                                                         |            |           |          |       |
| Maximum Junction-to-Case (Drain)                           | R <sub>thJC</sub>     | -                                                                                 |                                        | 2.3                                                     |            |           |          |       |
| <b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 $^{\circ}$ C, u | nless otherw          | vise noted)                                                                       |                                        |                                                         |            |           |          |       |
| PARAMETER                                                  | SYMBOL                | TES                                                                               | T CONDITI                              | ONS                                                     | MIN.       | TYP.      | MAX.     | UNIT  |
| Static                                                     |                       |                                                                                   |                                        |                                                         |            |           | •        |       |
| Drain-Source Breakdown Voltage                             | V <sub>DS</sub>       | V <sub>GS</sub> =                                                                 | = 0 V, I <sub>D</sub> = 2              | 50 µA                                                   | 1000       | -         | -        | V     |
| V <sub>DS</sub> Temperature Coefficient                    | $\Delta V_{DS}/T_{J}$ | Reference                                                                         | e to 25 °C,                            | I <sub>D</sub> = 1 mA                                   | -          | 1.2       | -        | V/°C  |
| Gate-Source Threshold Voltage                              | V <sub>GS(th)</sub>   | V <sub>DS</sub> =                                                                 | = V <sub>GS</sub> , I <sub>D</sub> = 2 | 50 µA                                                   | 2.0        | -         | 4.0      | V     |
| Gate-Source Leakage                                        | I <sub>GSS</sub>      |                                                                                   | V <sub>GS</sub> = ± 20 '               | V                                                       | -          | -         | ± 100    | nA    |
| Zero Gate Voltage Drain Current                            | I <sub>DSS</sub>      | V <sub>DS</sub> = 1000 V, V <sub>GS</sub> = 0 V                                   |                                        | -                                                       | -          | 100       | μA       |       |
| Loro auto Voltago Drain Garront                            | -055                  | -                                                                                 |                                        | T <sub>J</sub> = 125 °C                                 | -          | -         | 500      | μ     |
| Drain-Source On-State Resistance                           | R <sub>DS(on)</sub>   | $V_{GS} = 10 V$                                                                   | _                                      | = 0.84 A <sup>b</sup>                                   | -          | -         | 11       | Ω     |
| Forward Transconductance                                   | <b>g</b> fs           | V <sub>DS</sub> =                                                                 | 50 V, I <sub>D</sub> = 0               | 0.84 A <sup>b</sup>                                     | 1.0        | -         | -        | S     |
| Dynamic                                                    |                       | 1                                                                                 |                                        |                                                         | 1          |           | 1        | •     |
| Input Capacitance                                          | C <sub>iss</sub>      |                                                                                   | V <sub>GS</sub> = 0 V,                 |                                                         | -          | 500       | -        |       |
| Output Capacitance                                         | C <sub>oss</sub>      |                                                                                   | $V_{DS} = 25 V_{e}$                    |                                                         | -          | 52        | -        | pF    |
| Reverse Transfer Capacitance                               | C <sub>rss</sub>      | t = 1                                                                             | .0 MHz, see                            | tig. 5                                                  | -          | 17        | -        |       |
| Total Gate Charge                                          | Qg                    |                                                                                   |                                        |                                                         | -          | -         | 38       |       |
| Gate-Source Charge                                         | Q <sub>gs</sub>       | V <sub>GS</sub> = 10 V                                                            |                                        | A, V <sub>DS</sub> = 400 V,<br>J. 6 and 13 <sup>b</sup> | -          | -         | 4.9      | nC    |
| Gate-Drain Charge                                          | Q <sub>gd</sub>       |                                                                                   |                                        | ,                                                       | -          | -         | 22       |       |
| Turn-On Delay Time                                         | t <sub>d(on)</sub>    |                                                                                   |                                        |                                                         | -          | 9.4       | -        |       |
| Rise Time                                                  | t <sub>r</sub>        | -<br>V_D =                                                                        | 500 V, I <sub>D</sub> =                | 1.4 A.                                                  | -          | 17        | -        |       |
| Turn-Off Delay Time                                        | t <sub>d(off)</sub>   | $R_g = 18 \Omega$ ,                                                               | $R_D = 370 \Omega$                     | see fig. 10 <sup>b</sup>                                | -          | 58        | -        | ns    |
| Fall Time                                                  | t <sub>f</sub>        |                                                                                   |                                        |                                                         | -          | 31        | -        | 1     |
| Internal Drain Inductance                                  | L <sub>D</sub>        | Between lead<br>6 mm (0.25")                                                      | from                                   |                                                         | -          | 4.5       | -        |       |
| Internal Source Inductance                                 | L <sub>S</sub>        | package and die contact                                                           | center of                              |                                                         | -          | 7.5       | -        | nH    |
| Drain-Source Body Diode Characteristic                     | s                     |                                                                                   |                                        |                                                         |            |           |          |       |
| Continuous Source-Drain Diode Current                      | IS                    | MOSFET sym<br>showing the                                                         |                                        |                                                         | -          | -         | 1.4      | A     |
| Pulsed Diode Forward Current <sup>a</sup>                  | I <sub>SM</sub>       | p - n junction diode                                                              |                                        | -                                                       | -          | 5.6       |          |       |
| Body Diode Voltage                                         | V <sub>SD</sub>       | T <sub>J</sub> = 25 °C                                                            | , I <sub>S</sub> = 1.4 A,              | $V_{GS} = 0 V^{b}$                                      | -          | -         | 1.5      | V     |
| Body Diode Reverse Recovery Time                           | t <sub>rr</sub>       | T 05 00 1                                                                         | 4 4 4                                  | -# 100 A/ -b                                            | -          | 130       | 190      | ns    |
| Body Diode Reverse Recovery Charge                         | Q <sub>rr</sub>       | $T_J = 25 \text{ °C}, I_F = 1.4 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}^{b}$ |                                        |                                                         | -          | 0.46      | 0.69     | μC    |
| Forward Turn-On Time                                       | t <sub>on</sub>       | Intrinsic ti                                                                      | rn-on time i                           | s negligible (turn                                      | -on is dor | ninated h | v La and | <br>) |

#### Notes

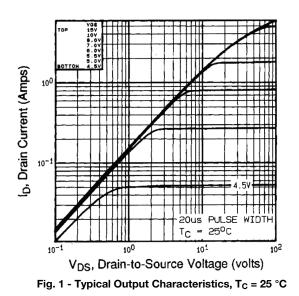
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.

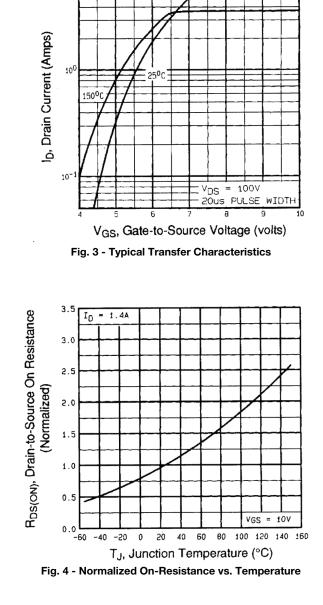
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#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



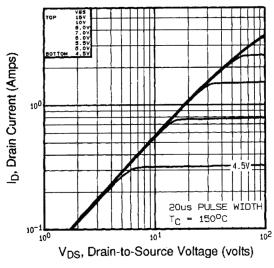


Fig. 2 -Typical Output Characteristics, T<sub>C</sub> = 150 °C

Document Number: 91123 S11-0516-Rev. B, 21-Mar-11 www.vishay.com

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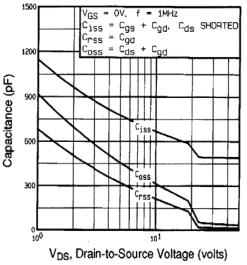


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

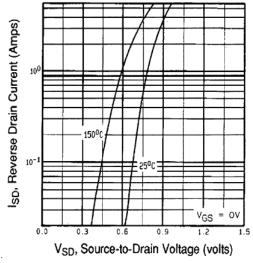


Fig. 7 - Typical Source-Drain Diode Forward Voltage

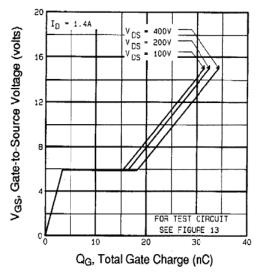
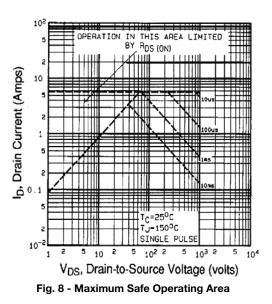


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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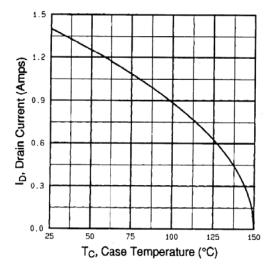


Fig. 9 - Maximum Drain Current vs. Case Temperature

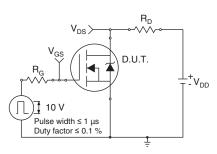


Fig. 10a - Switching Time Test Circuit

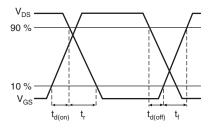
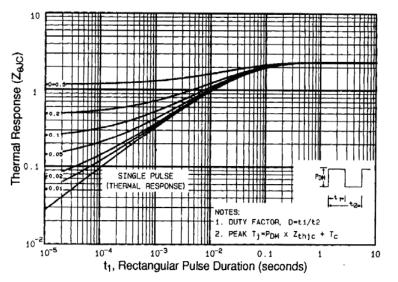
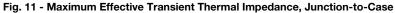
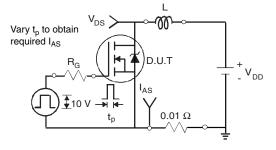
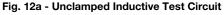


Fig. 10b - Switching Time Waveforms









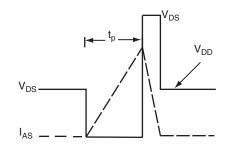


Fig. 12b - Unclamped Inductive Waveforms

Document Number: 91123 S11-0516-Rev. B, 21-Mar-11

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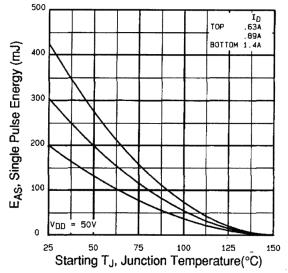


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

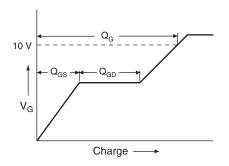


Fig. 13a - Basic Gate Charge Waveform

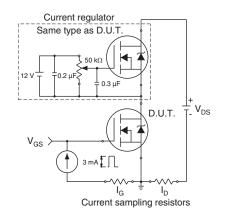
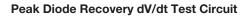


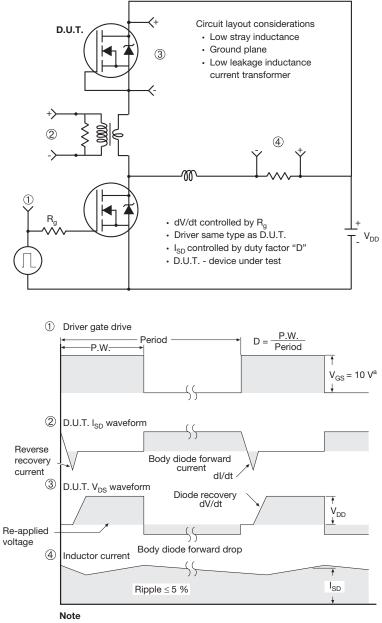
Fig. 13b - Gate Charge Test Circuit

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a.  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel

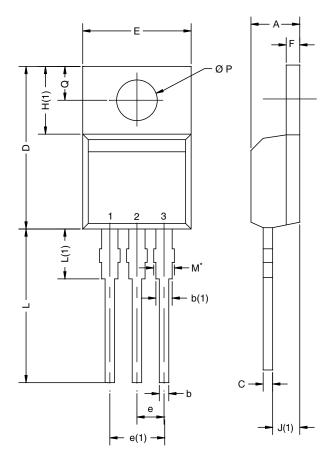
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### **TO-220AB**



|                       | MILLIN            | IETERS    | INC   | HES   |
|-----------------------|-------------------|-----------|-------|-------|
| DIM.                  | MIN.              | MAX.      | MIN.  | MAX.  |
| А                     | 4.25              | 4.65      | 0.167 | 0.183 |
| b                     | 0.69              | 1.01      | 0.027 | 0.040 |
| b(1)                  | 1.20              | 1.73      | 0.047 | 0.068 |
| С                     | 0.36              | 0.61      | 0.014 | 0.024 |
| D                     | 14.85             | 15.49     | 0.585 | 0.610 |
| E                     | 10.04             | 10.51     | 0.395 | 0.414 |
| е                     | 2.41              | 2.67      | 0.095 | 0.105 |
| e(1)                  | 4.88              | 5.28      | 0.192 | 0.208 |
| F                     | 1.14              | 1.40      | 0.045 | 0.055 |
| H(1)                  | 6.09              | 6.48      | 0.240 | 0.255 |
| J(1)                  | 2.41              | 2.92      | 0.095 | 0.115 |
| L                     | 13.35             | 14.02     | 0.526 | 0.552 |
| L(1)                  | 3.32              | 3.82      | 0.131 | 0.150 |
| ØР                    | 3.54              | 3.94      | 0.139 | 0.155 |
| Q                     | 2.60              | 3.00      | 0.102 | 0.118 |
| ECN: T13-<br>DWG: 547 | 0724-Rev. O,<br>1 | 14-Oct-13 |       |       |

#### Note

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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